Search Notes

Applicati	on/Co	ntrol No.
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Applicant(s)/Patent under Reexamination

10/691,212 Examiner

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DORNBUSCH ET AL.

Art Unit

Chris C. Chu

2815

SEARCHED					
Class	Subclass	Date	Examiner		
257	E23.052, E23.079, 786 & 778	5/13/2007	C.C.		
257	686	5/13/2007	C.C.		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
Searched in US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; FPRS; and IBM_TDB;	5/13/2007	C.C.